

<b>Notice of References Cited</b>		Application/Control No. 10/725,450	Applicant(s)/Patent Under Reexamination ANDOH ET AL.	
		Examiner karen masih	Art Unit 2837	Page 1 of 1

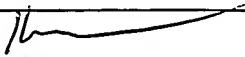
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	 <b>Karen Masih</b> <b>Primary Examiner</b>
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.